

*flow*BOOST 0

1200V/50A
Features

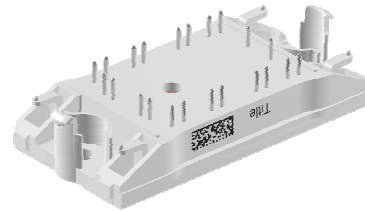
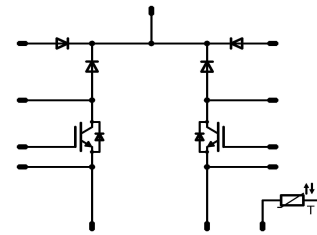
- High efficiency dual boost
- Ultra fast switching frequency
- Low Inductance Layout
- 1200V IGBT and 1200V SiC diode
- Antiparallel IGBT protection diode with high current

Target Applications

- solar inverter

Types

- V23990-P629-L63

flow0 12mm housing

Schematic


Maximum Ratings

 $T_j=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit	
D7-D10					
Repetitive peak reverse voltage	V_{RRM}		1600	V	
Forward average current	I_{FAV}	$T_j=T_{jmax}$	$T_h=80^\circ\text{C}$	38	A
			$T_c=80^\circ\text{C}$	45	
Surge forward current	I_{FSM}	$t_p=10\text{ms}$	$T_j=25^\circ\text{C}$	220	A
l2t-value	I^2t			200	A^2s
Power dissipation per Diode	P_{tot}	$T_j=T_{jmax}$	$T_h=80^\circ\text{C}$	47	W
			$T_c=80^\circ\text{C}$	71	
Maximum Junction Temperature	T_{jmax}		150	$^\circ\text{C}$	

T1,T2

Collector-emitter break down voltage	V_{CES}		1200	V	
DC collector current	I_C	$T_j=T_{jmax}$	$T_h=80^\circ\text{C}$	43	A
			$T_c=80^\circ\text{C}$	57	
Pulsed collector current	I_{Cpulse}	t_p limited by T_{jmax}	160	A	
Power dissipation per IGBT	P_{tot}	$T_j=T_{jmax}$	$T_h=80^\circ\text{C}$	145	W
			$T_c=80^\circ\text{C}$	220	
Gate-emitter peak voltage	V_{GE}		± 20	V	
Short circuit ratings	t_{SC}	$T_j \leq 150^\circ\text{C}$	10	μs	
	V_{CC}	$V_{GE}=15\text{V}$	600	V	
Maximum Junction Temperature	T_{jmax}		175	$^\circ\text{C}$	

Maximum Ratings

$T_j=25^{\circ}\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit	
D1,D2,D3,D4,D5,D6 *					
Peak Repetitive Reverse Voltage	V_{RRM}		1200	V	
Forward average current	I_{FAV}	$T_j=T_{j,max}$	$T_h=80^{\circ}\text{C}$	28	A
			$T_c=80^{\circ}\text{C}$	34	
Surge forward current	I_{FSM}	$t_p=10\text{ms}$	$T_j=25^{\circ}\text{C}$	138	A
I ² t-value	I^2t			95	A ² s
Repetitive peak forward current	I_{FRM}	t_p limited by $T_{j,max}$	78	A	
Power dissipation per Diode	P_{tot}	$T_j=T_{j,max}$	$T_h=80^{\circ}\text{C}$	81	W
			$T_c=80^{\circ}\text{C}$	123	
Maximum Junction Temperature	$T_{j,max}$		175	$^{\circ}\text{C}$	

Thermal Properties

Storage temperature	T_{stg}		-40...+125	$^{\circ}\text{C}$
Operation temperature under switching condition	T_{op}		-40...+($T_{j,max} - 25$)	$^{\circ}\text{C}$

Insulation Properties

Insulation voltage		$t=2\text{s}$ DC voltage	4000	V
Creepage distance			min 12,7	mm
Clearance			min 12,7	mm

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		V_{GE} [V] or V_{GS} [V]	V_r [V] or V_{CE} [V] or V_{DS} [V]	I_c [A] or I_F [A] or I_b [A]	T_j	Min	Typ	Max		
D7-D10										
Forward voltage	V_F			25	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	0,8	1,14 1,10	1,9		V
Threshold voltage (for power loss calc. only)	V_{to}			25	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,92 0,80			V
Slope resistance (for power loss calc. only)	r_t			25	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,009 0,012			Ω
Reverse current	I_r		1500		$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$			0,05		mA
Thermal resistance chip to heatsink per chip	R_{thJH}	Phase-Change Material					1,49			K/W
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness $\leq 50\mu\text{m}$ $\lambda = 1 \text{ W/K}$					1,73			K/W

T1,T2

Gate emitter threshold voltage	$V_{GE(th)}$	$V_{GE}=V_{CE}$			0,00025	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	3,5	5,5	7,5	V			
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		50	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	1,5	3,16 3,42	2,5	V			
Collector-emitter cut-off	I_{CES}		0	1200		$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$			1	mA			
Gate-emitter leakage current	I_{GES}		20	0		$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	250		250	nA			
Integrated Gate resistor	R_{gint}							4		Ω			
Turn-on delay time	$t_{d(on)}$	$R_{goff}=4 \Omega$ $R_{gon}=4 \Omega$	15	700	40	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		24 23		ns			
Rise time	t_r					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$					11		
Turn-off delay time	$t_{d(off)}$					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$						178 208	
Fall time	t_f					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$							11 39
Turn-on energy loss per pulse	E_{on}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$							
Turn-off energy loss per pulse	E_{off}	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	0,934 1,760										
Input capacitance	C_{ies}	$f=1\text{MHz}$		0	25		$T_j=25^\circ\text{C}$		3200		pF		
Output capacitance	C_{oss}												
Reverse transfer capacitance	C_{rss}											125	
Gate charge	Q_{Gate}			15	600	40	$T_j=25^\circ\text{C}$		220	330	nC		
Thermal resistance chip to heatsink per chip	R_{thJH}	Phase-Change Material						0,65		K/W			
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness $\leq 50\mu\text{m}$ $\lambda = 1 \text{ W/K}$						0,43		K/W			

D1,D2,D3,D4,D5,D6 *

Forward voltage	V_F				15	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		1,43 1,69	2	V				
Reverse leakage current	I_{rm}			1200		$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$			150	μA				
Peak recovery current	I_{RRM}	$R_{gon}=4 \Omega$	15	700	40	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		17 15		A				
Reverse recovery time	t_{rr}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$					9 9			
Reverse recovery charge	Q_{rr}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$						0,24 0,21		
Reverse recovered energy	E_{rec}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$							0,093 0,074	
Peak rate of fall of recovery current	$di(rec)_{max}/dt$					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$								6570 5559
Thermal resistance chip to heatsink per chip	R_{thJH}					Phase-Change Material								
Thermal resistance chip to case per chip	R_{thJC}	Thermal grease thickness $\leq 50\mu\text{m}$ $\lambda = 1 \text{ W/K}$					1,36		K/W					

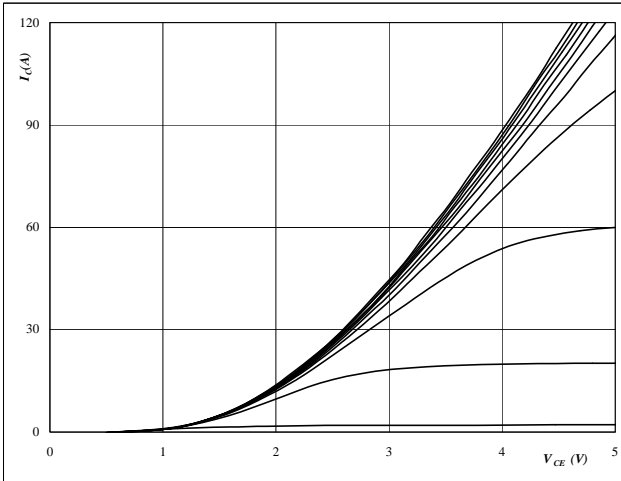
Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		V_{GE} [V] or V_{GS} [V]	V_r [V] or V_{CE} [V] or V_{DS} [V]	I_C [A] or I_F [A] or I_b [A]	T_j	Min	Typ	Max		
Thermistor										
Rated resistance	R					T=25°C		21511		Ω
Deviation of R100	$\Delta R/R$	R100=1486 Ω				T=25°C	-4,5		+4,5	%
Power dissipation	P					T=25°C		210		mW
Power dissipation constant						T=25°C		3,5		mW/K
B-value	B(25/50)	Tol. ±3%				T=25°C		3884		K
B-value	B(25/100)	Tol. ±3%				T=25°C		3964		K
Vincotech NTC Reference									F	

T1, T2
Figure 1 T1, T2

Typical output characteristics

$I_D = f(V_{DS})$

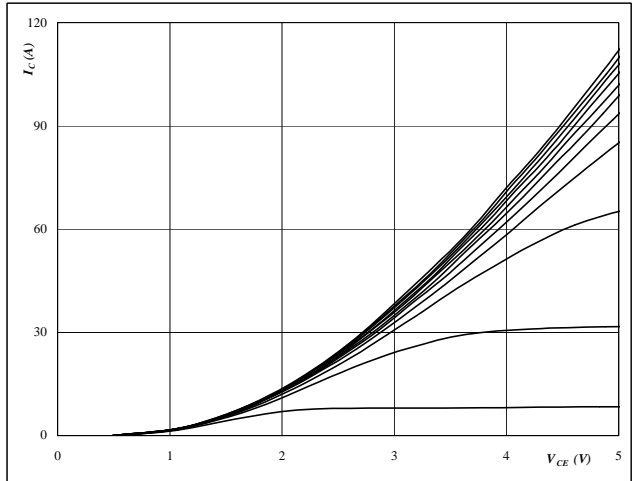


At
 $t_p = 250 \mu s$
 $T_j = 25 \text{ } ^\circ C$
 V_{GS} from 7 V to 17 V in steps of 1 V

Figure 2 T1, T2

Typical output characteristics

$I_D = f(V_{DS})$

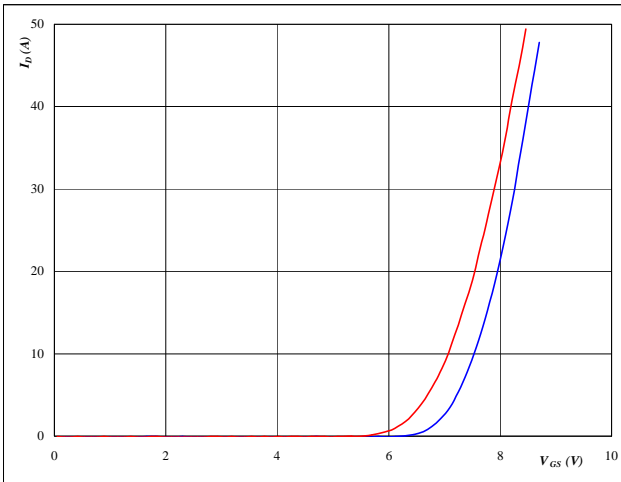


At
 $t_p = 250 \mu s$
 $T_j = 126 \text{ } ^\circ C$
 V_{GS} from 7 V to 17 V in steps of 1 V

Figure 3 T1, T2

Typical transfer characteristics

$I_D = f(V_{GS})$

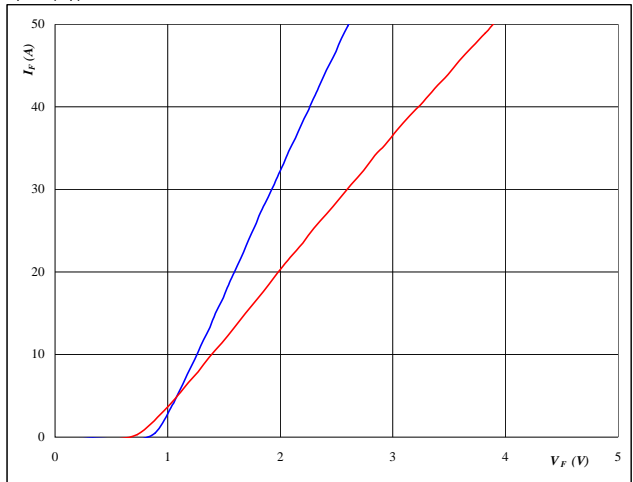


At
 $t_p = 100 \mu s$
 $V_{DS} = 10 V$
 $T_j = 25/125 \text{ } ^\circ C$

Figure 4 T1, T2

Typical diode forward current as a function of forward voltage

$I_F = f(V_F)$

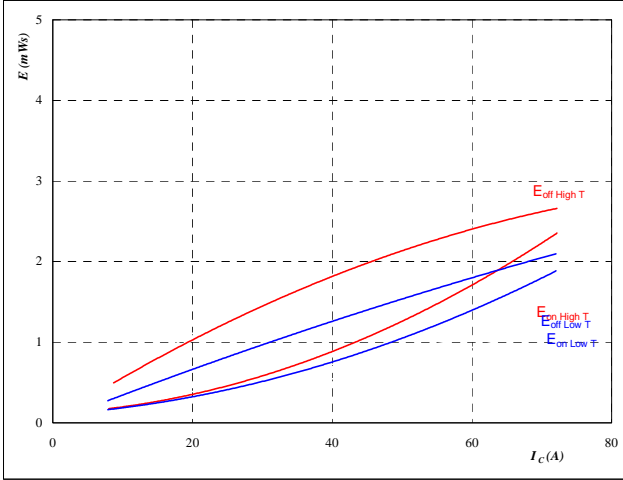


At
 $t_p = 250 \mu s$
 $T_j = 25/125 \text{ } ^\circ C$

T1, T2

Figure 5 T1, T2

Typical switching energy losses
as a function of collector current
 $E = f(I_c)$

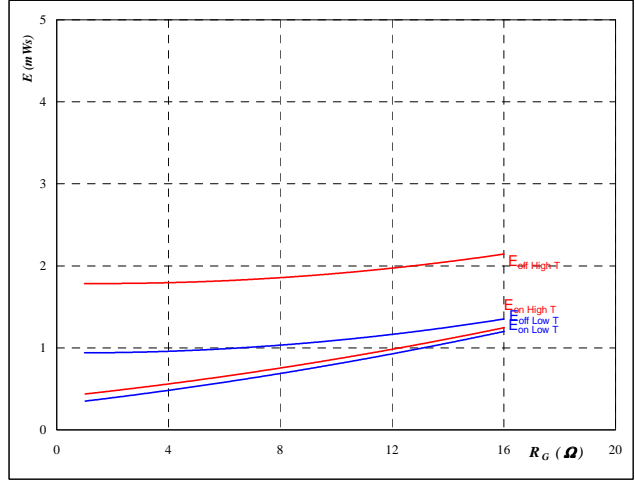


With an inductive load at

$T_j = 25/125$ °C
 $V_{DS} = 700$ V
 $V_{GS} = 15$ V
 $R_{gon} = 4$ Ω
 $R_{goff} = 4$ Ω

Figure 6 T1, T2

Typical switching energy losses
as a function of gate resistor
 $E = f(R_G)$

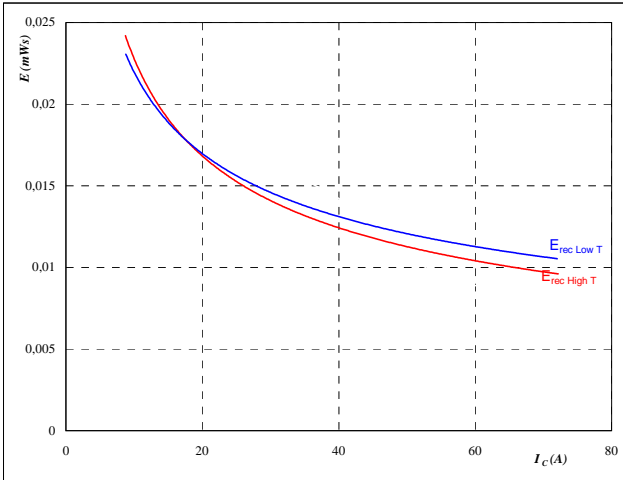


With an inductive load at

$T_j = 25/125$ °C
 $V_{DS} = 700$ V
 $V_{GS} = 15$ V
 $I_D = 40$ A

Figure 7 D1, D2, D3, D4, D5, D6

Typical reverse recovery energy loss
as a function of collector (drain) current
 $E_{rec} = f(I_c)$

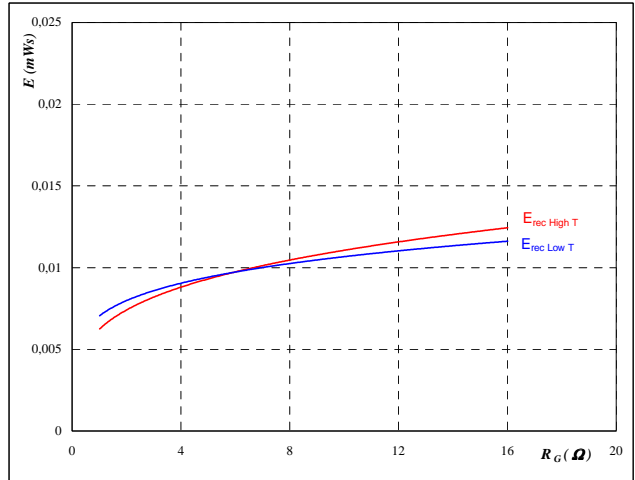


With an inductive load at

$T_j = 25/125$ °C
 $V_{DS} = 700$ V
 $V_{GS} = 15$ V
 $R_{gon} = 4$ Ω
 $R_{goff} = 4$ Ω

Figure 8 D1, D2, D3, D4, D5, D6

Typical reverse recovery energy loss
as a function of gate resistor
 $E_{rec} = f(R_G)$



With an inductive load at

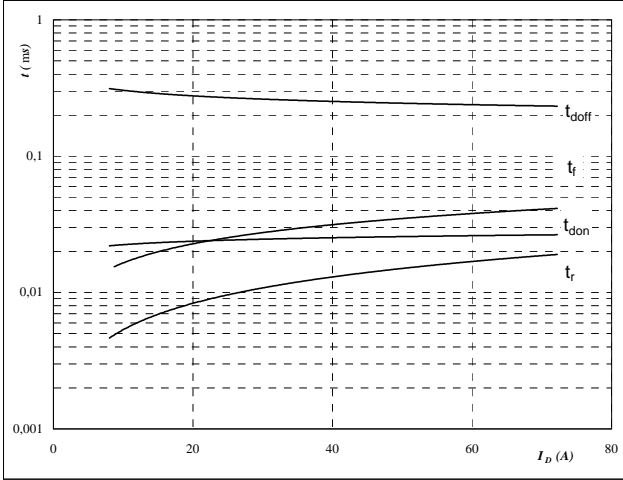
$T_j = 25/125$ °C
 $V_{DS} = 700$ V
 $V_{GS} = 15$ V
 $I_D = 40$ A

T1, T2

Figure 9 T1, T2

Typical switching times as a function of collector current

$t = f(I_C)$



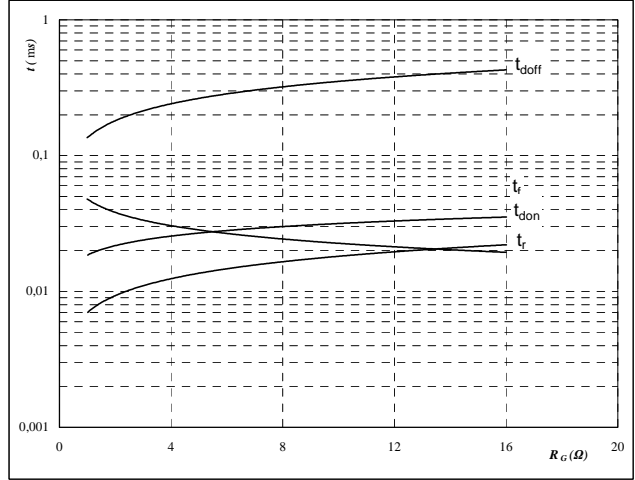
With an inductive load at

$T_j =$	125	°C
$V_{DS} =$	700	V
$V_{GS} =$	15	V
$R_{gon} =$	4	Ω
$R_{goff} =$	4	Ω

Figure 10 T1, T2

Typical switching times as a function of gate resistor

$t = f(R_G)$



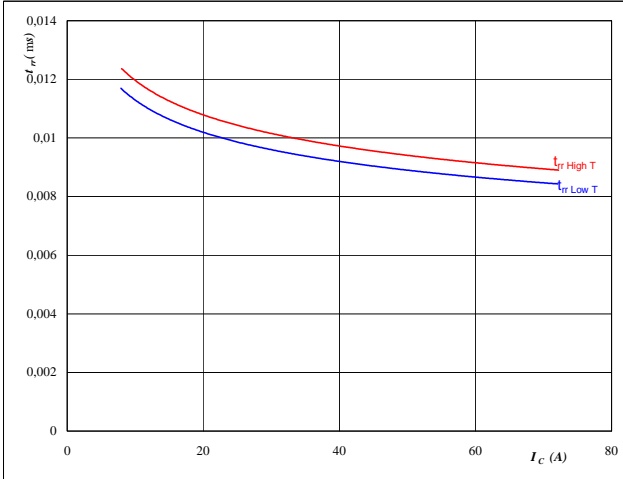
With an inductive load at

$T_j =$	125	°C
$V_{DS} =$	700	V
$V_{GS} =$	15	V
$I_C =$	40	A

Figure 11 D1, D2, D3, D4, D5, D6

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$



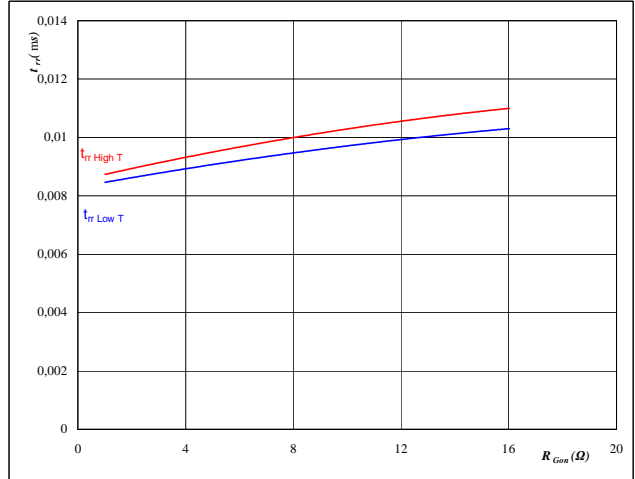
At

$T_j =$	25/125	°C
$V_{CE} =$	700	V
$V_{GE} =$	15	V
$R_{gon} =$	4	Ω

Figure 12 D1, D2, D3, D4, D5, D6

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$



At

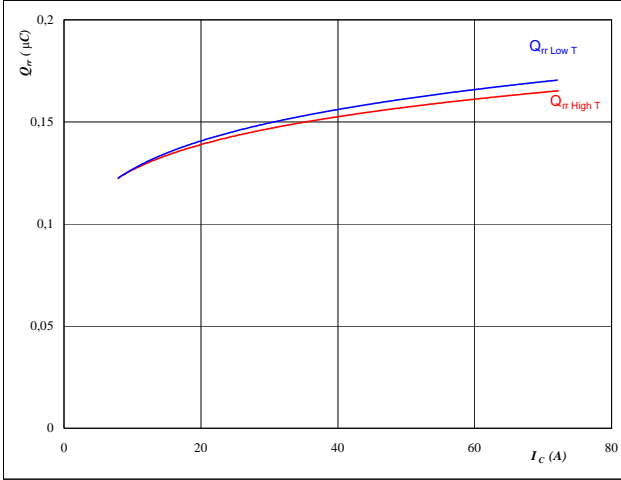
$T_j =$	25/125	°C
$V_R =$	700	V
$I_F =$	40	A
$V_{GS} =$	15	V

T1, T2

Figure 13 D1, D2, D3, D4, D5, D6

Typical reverse recovery charge as a function of collector current

$Q_{rr} = f(I_c)$

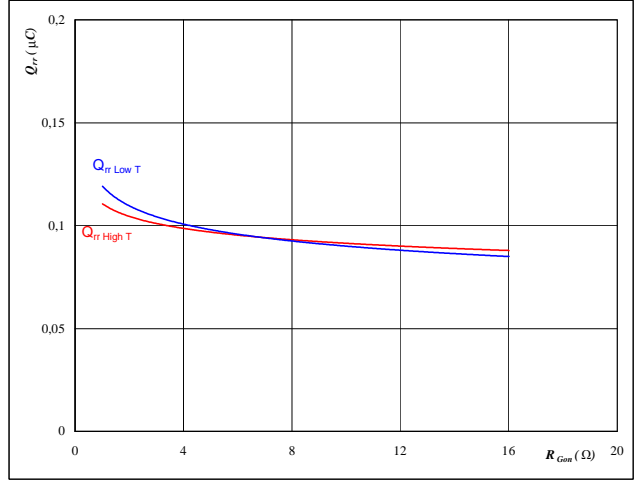


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_{CE} = 700 \text{ V}$
 $V_{GE} = 15 \text{ V}$
 $R_{gon} = 4 \text{ } \Omega$

Figure 14 D1, D2, D3, D4, D5, D6

Typical reverse recovery charge as a function of IGBT turn on gate resistor

$Q_{rr} = f(R_{gon})$

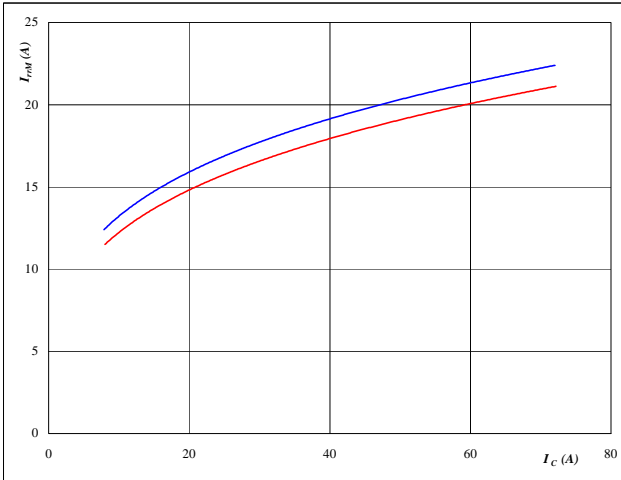


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_R = 700 \text{ V}$
 $I_F = 40 \text{ A}$
 $V_{GS} = 15 \text{ V}$

Figure 15 D1, D2, D3, D4, D5, D6

Typical reverse recovery current as a function of collector current

$I_{RRM} = f(I_c)$

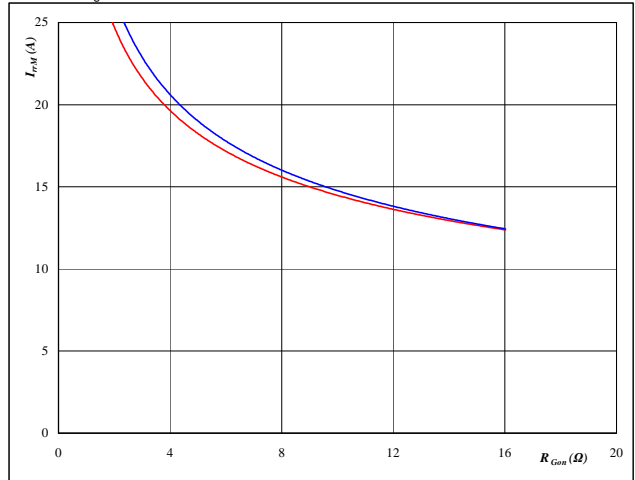


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_{CE} = 700 \text{ V}$
 $V_{GE} = 15 \text{ V}$
 $R_{gon} = 4 \text{ } \Omega$

Figure 16 D1, D2, D3, D4, D5, D6

Typical reverse recovery current as a function of IGBT turn on gate resistor

$I_{RRM} = f(R_{gon})$



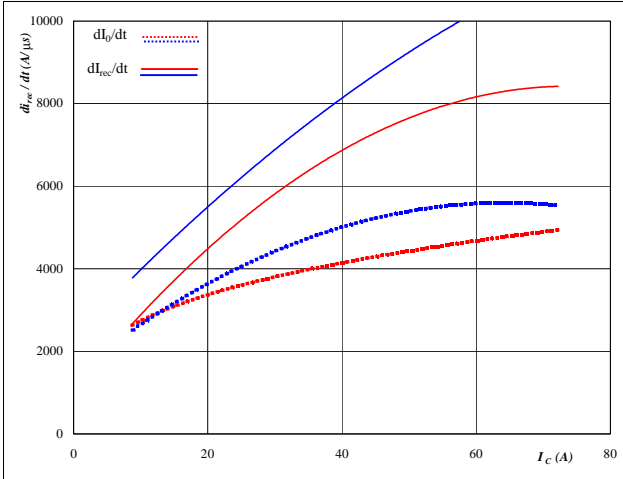
At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_R = 700 \text{ V}$
 $I_F = 40 \text{ A}$
 $V_{GS} = 15 \text{ V}$

T1, T2

Figure 17 D1, D2, D3, D4, D5, D6

Typical rate of fall of forward and reverse recovery current as a function of collector current

$dI_f/dt, dI_{rec}/dt = f(I_c)$

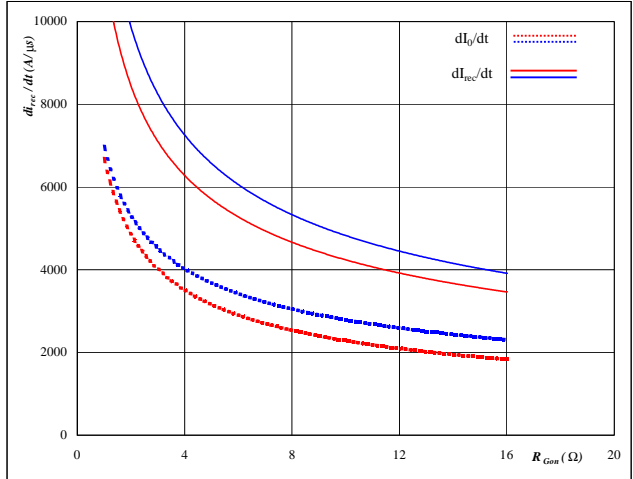


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_{CE} = 700 \text{ V}$
 $V_{GE} = 15 \text{ V}$
 $R_{gon} = 4 \text{ } \Omega$

Figure 18 D1, D2, D3, D4, D5, D6

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

$dI_f/dt, dI_{rec}/dt = f(R_{gon})$

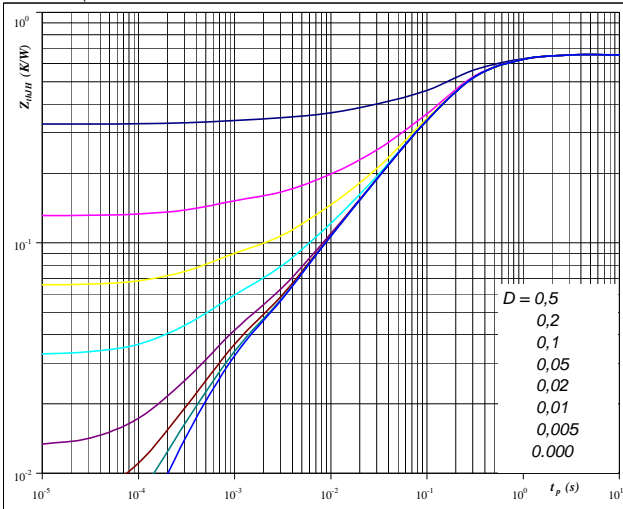


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_R = 700 \text{ V}$
 $I_F = 40 \text{ A}$
 $V_{GS} = 15 \text{ V}$

Figure 19 T1, T2

IGBT/MOSFET transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



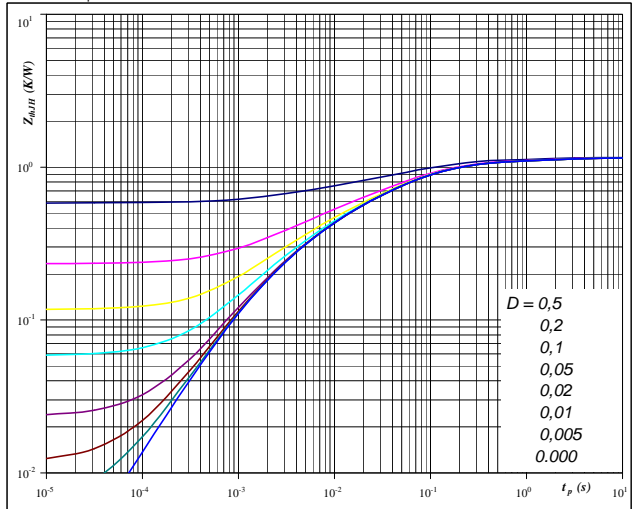
At
 $D = t_p / T$
 Phase-Change Material Thermal grease
 $R_{thJH} = 0,65 \text{ K/W}$ $R_{thJH} = 0,79 \text{ K/W}$
 IGBT thermal model values

Phase-Change Material		Thermal grease	
R (C/W)	Tau (s)	R (C/W)	Tau (s)
0,173	0,561	0,208	0,561
0,381	0,125	0,459	0,125
0,078	0,010	0,094	0,010
-0,003	0,048	-0,004	0,048
0,026	0,001	0,032	0,001

Figure 20 D1, D2, D3, D4, D5, D6

FWD transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



At
 $D = t_p / T$
 Phase-Change Material Thermal grease
 $R_{thJH} = 1,17 \text{ K/W}$ $R_{thJH} = 1,36 \text{ K/W}$
 FWD thermal model values

Phase-Change Material		Thermal grease	
R (C/W)	Tau (s)	R (C/W)	Tau (s)
0,043	9,803	0,050	9,80
0,101	0,815	0,118	0,82
0,383	0,098	0,445	0,10
0,308	0,026	0,358	0,03
0,233	0,005	0,271	0,01
0,098	0,001	0,114	0,00

T1, T2

Figure 21 T1, T2

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

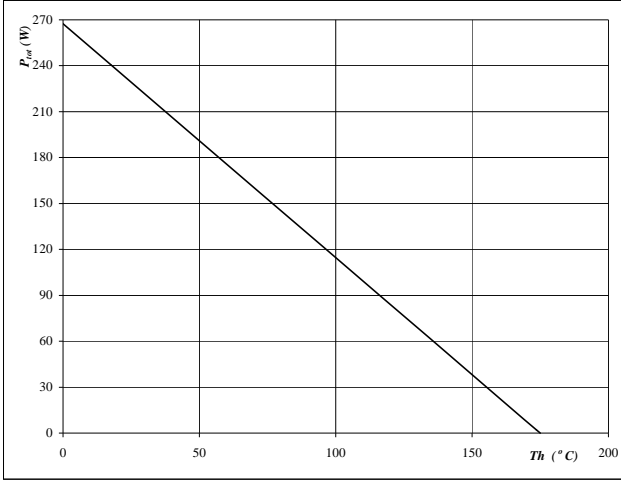

At
 $T_j = 175$ °C

Figure 22 T1, T2

Collector/Drain current as a function of heatsink temperature

$$I_C = f(T_h)$$

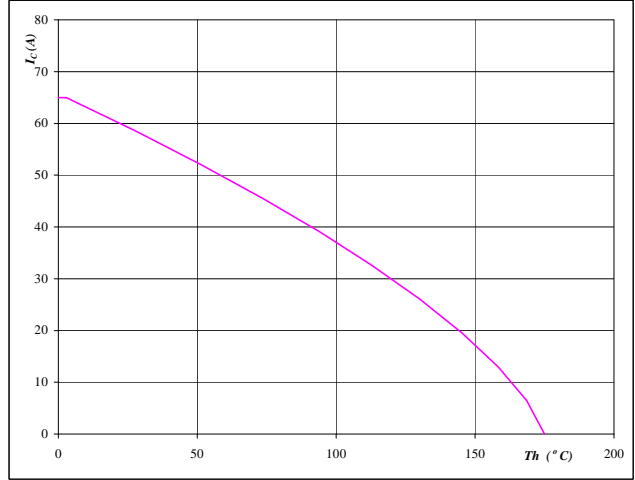

At
 $T_j = 175$ °C
 $V_{GS} = 15$ V

Figure 23 D1, D2, D3, D4, D5, D6

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

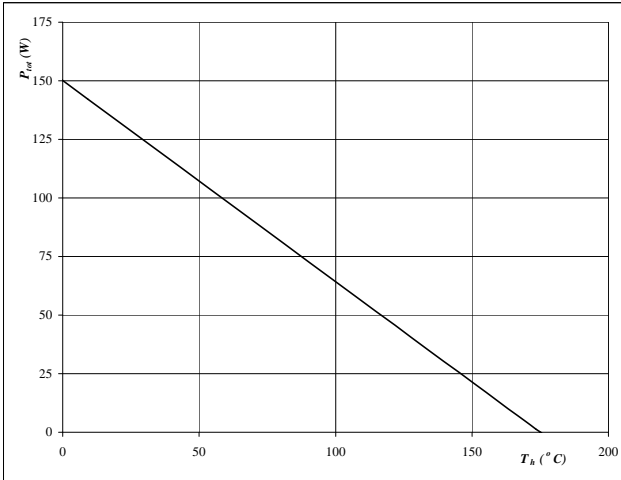
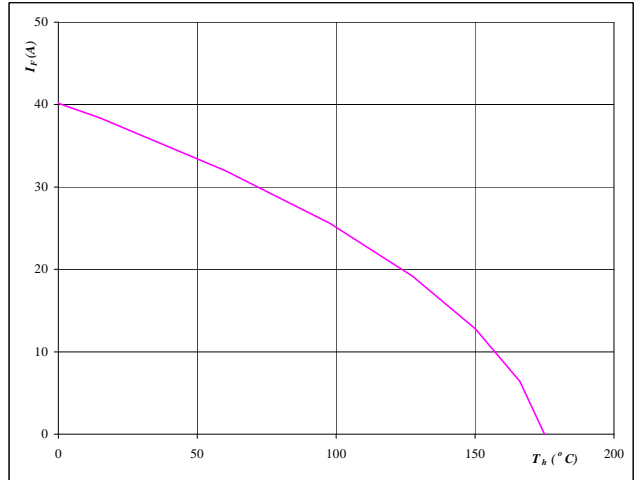

At
 $T_j = 175$ °C

Figure 24 D1, D2, D3, D4, D5, D6

Forward current as a function of heatsink temperature

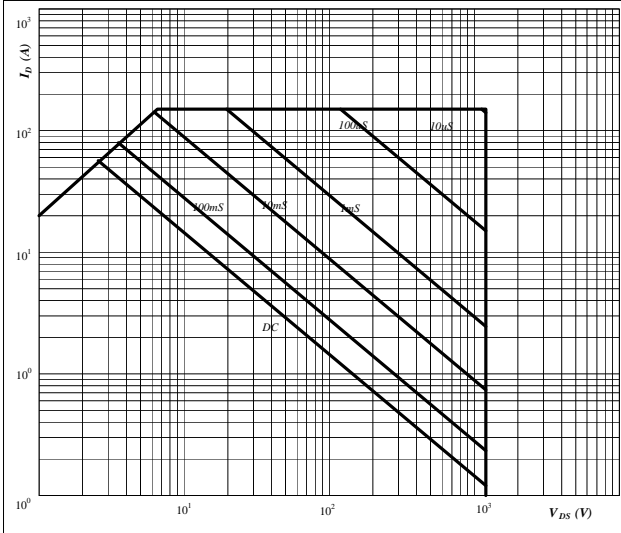
$$I_F = f(T_h)$$


At
 $T_j = 175$ °C

T1, T2

Figure 25 T1, T2

Safe operating area as a function of drain-source voltage
 $I_D = f(V_{DS})$

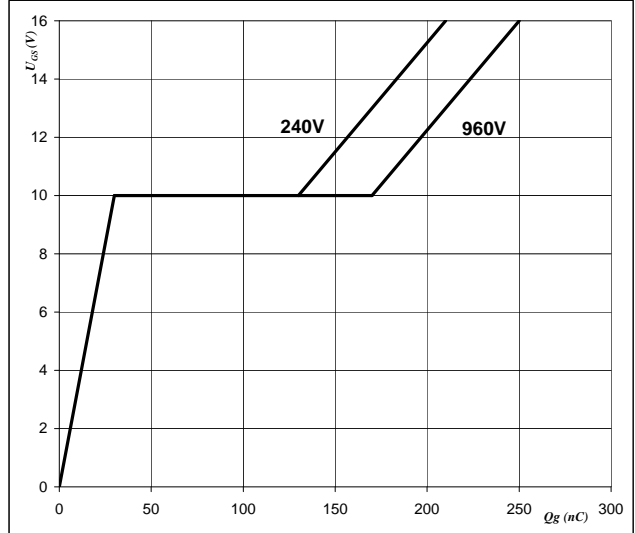


At
 D = single pulse
 $T_h = 80$ °C
 $V_{GS} = 15$ V
 $T_j = T_{jmax}$ °C

Figure 26 T1, T2

Gate voltage vs Gate charge

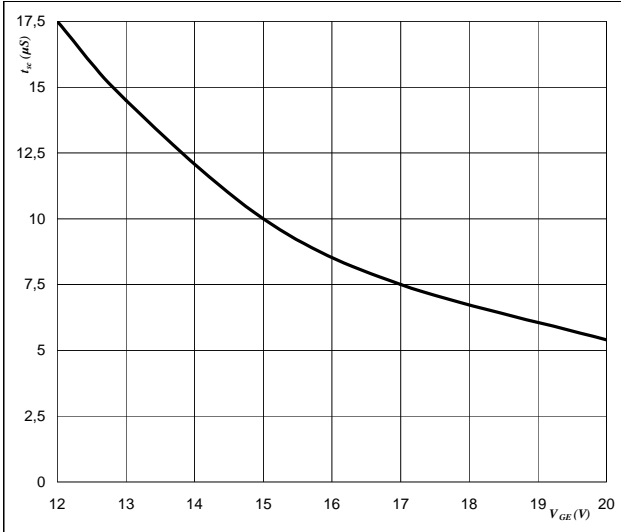
$V_{GS} = f(Q_g)$



At
 $I_D = 50$ A

Figure 27 T1, T2

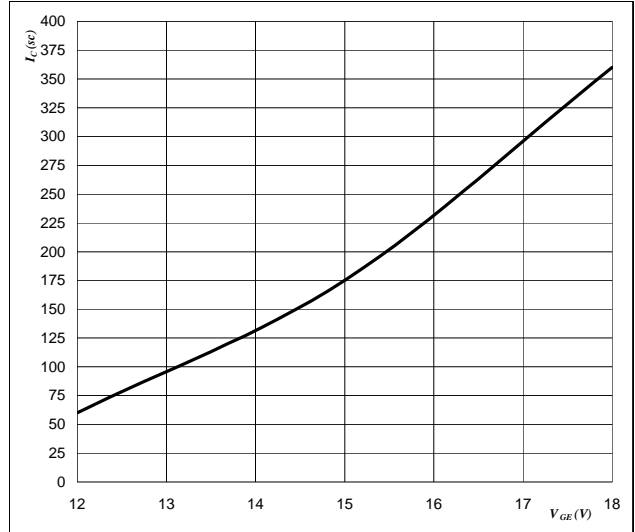
Short circuit withstand time as a function of gate-emitter voltage
 $t_{sc} = f(V_{GE})$



At
 $V_{CE} = 600$ V
 $T_j \leq 150$ °C

Figure 28 T1, T2

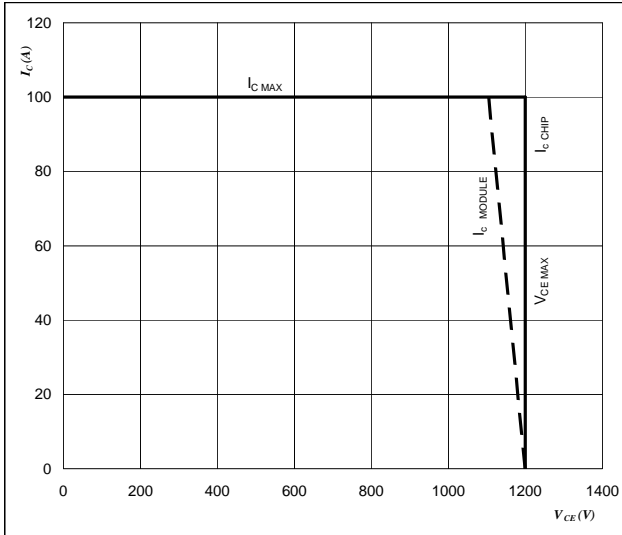
Typical short circuit collector current as a function of gate-emitter voltage
 $V_{GE} = f(Q_{GE})$



At
 $V_{CE} \leq 600$ V
 $T_j = 25$ °C

T1, T2
Figure 29 T1, T2
Reverse bias safe operating area

$$I_C = f(V_{CE})$$


At
 $T_{vj} \leq 150$ °C

 $I_{C\ MAX} = 100$ A

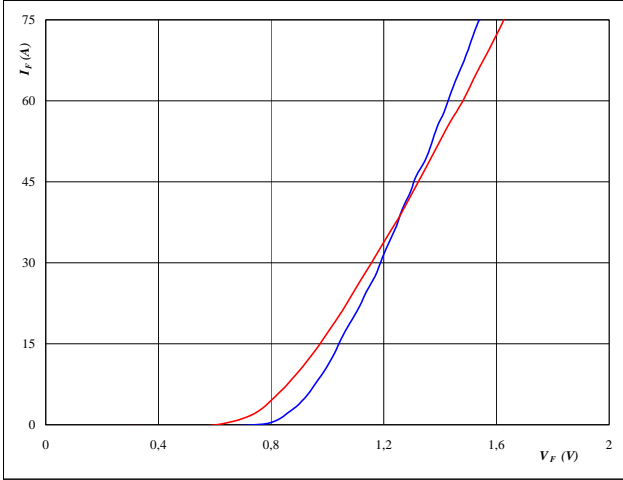
 $U_{CE\ MAX} = 1200$ V

D7-D10

Figure 1 D7-D10

Typical diode forward current as a function of forward voltage

$I_F = f(V_F)$

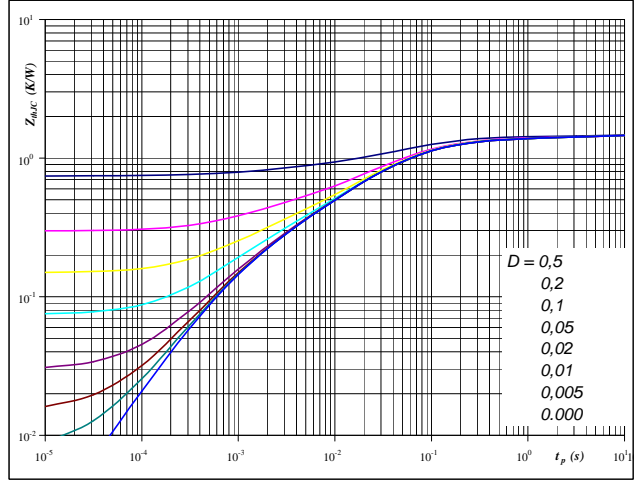


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $t_p = 250 \text{ } \mu\text{s}$

Figure 2 D7-D10

Diode transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$

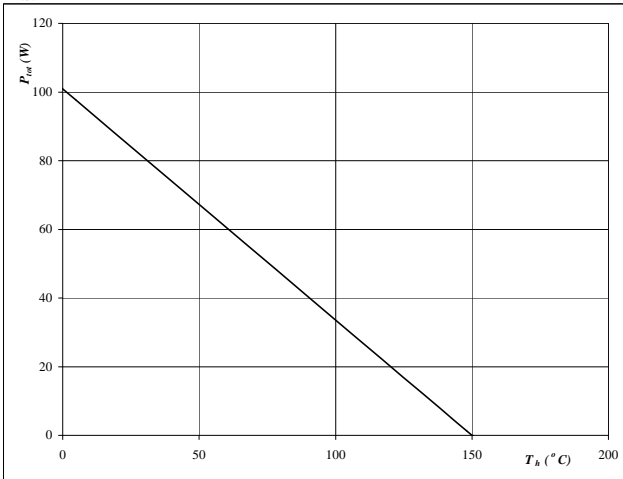


At
 $D = t_p / T$
 Phase-Change Material $R_{thJH} = 1,49 \text{ K/W}$
 Thermal grease $R_{thJH} = 1,73 \text{ K/W}$

Figure 3 D7-D10

Power dissipation as a function of heatsink temperature

$P_{tot} = f(T_h)$

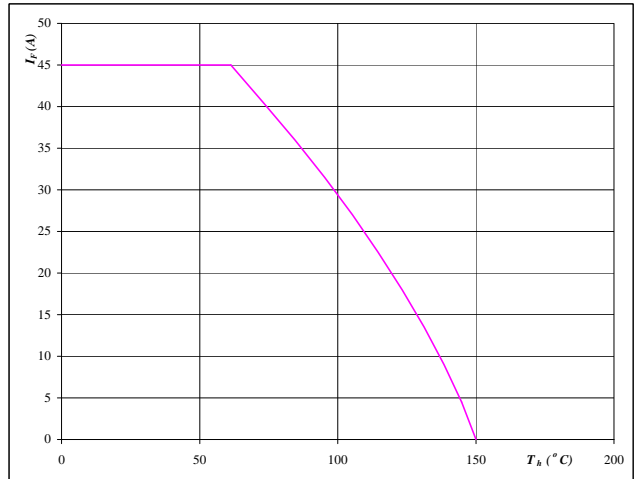


At
 $T_j = 150 \text{ } ^\circ\text{C}$

Figure 4 D7-D10

Forward current as a function of heatsink temperature

$I_F = f(T_h)$



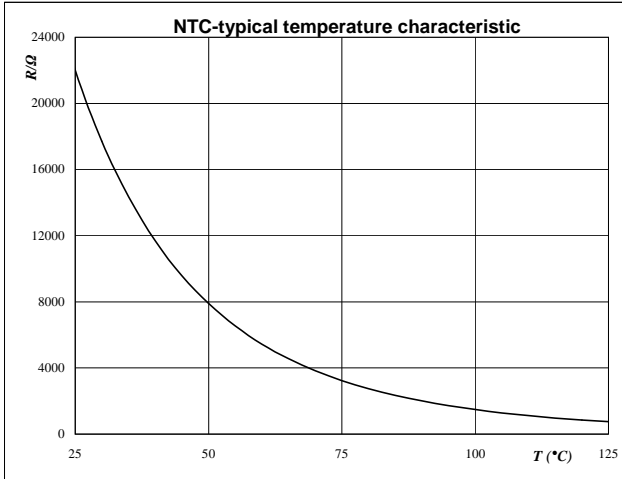
At
 $T_j = 150 \text{ } ^\circ\text{C}$

Thermistor

Figure 1 Thermistor

**Typical NTC characteristic
as a function of temperature**

$$R_T = f(T)$$

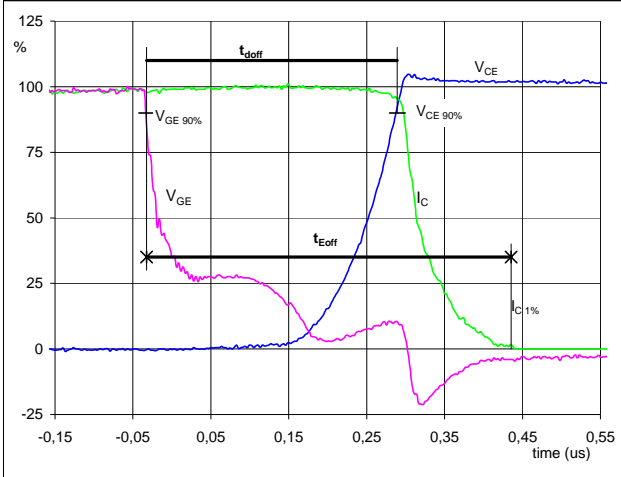


Switching Definitions Boost

General conditions	
T_j	= 125 °C
R_{gon}	= 4 Ω
R_{goff}	= 4 Ω

Figure 1 T1, T2

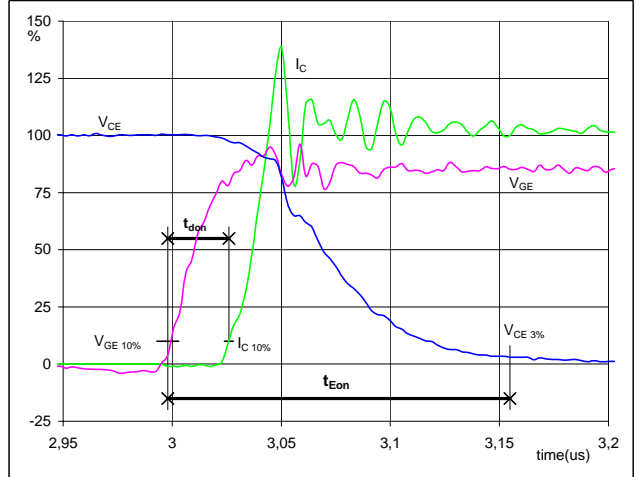
Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
 (t_{Eoff} = integrating time for E_{off})



$V_{GE}(0\%) =$	0	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	700	V
$I_C(100\%) =$	40	A
$t_{doff} =$	0,320	μs
$t_{Eoff} =$	0,468	μs

Figure 2 T1, T2

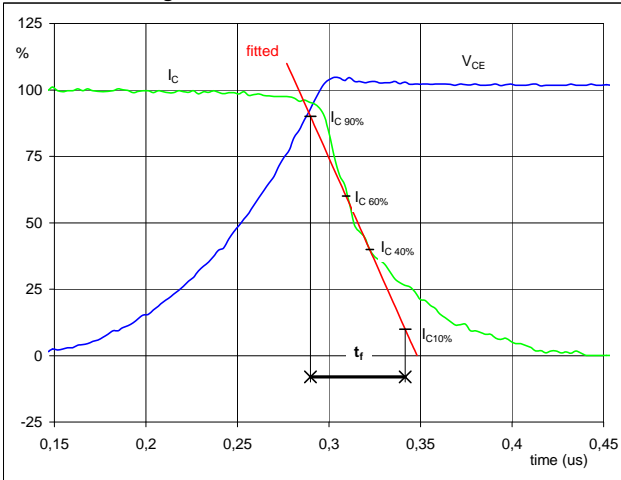
Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
 (t_{Eon} = integrating time for E_{on})



$V_{GE}(0\%) =$	0	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	700	V
$I_C(100\%) =$	40	A
$t_{don} =$	0,027	μs
$t_{Eon} =$	0,157	μs

Figure 3 T1, T2

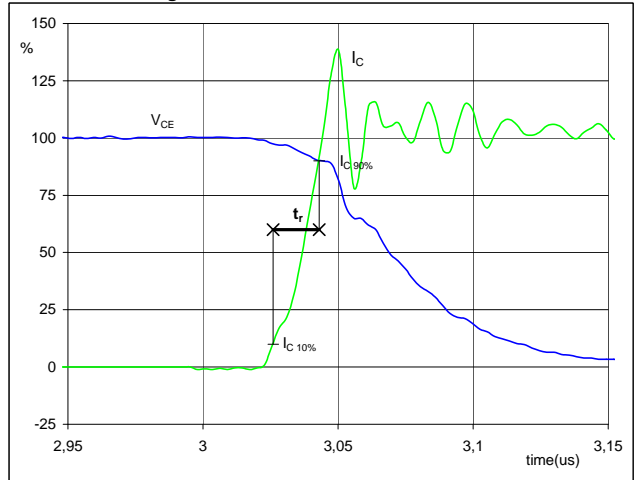
Turn-off Switching Waveforms & definition of t_f



$V_C(100\%) =$	700	V
$I_C(100\%) =$	40	A
$t_f =$	0,057	μs

Figure 4 T1, T2

Turn-on Switching Waveforms & definition of t_r

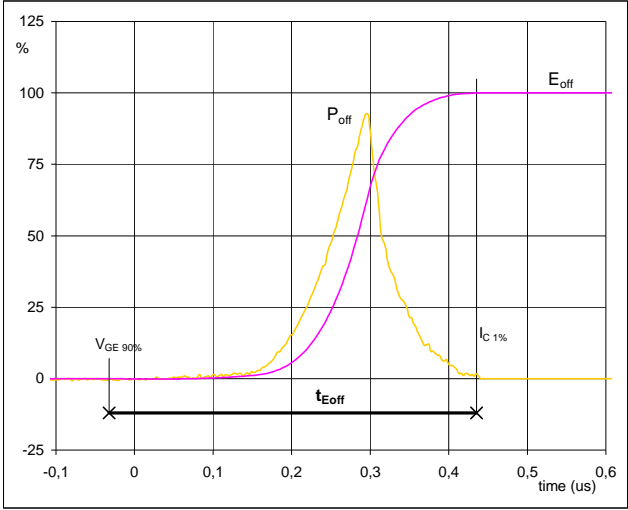


$V_C(100\%) =$	700	V
$I_C(100\%) =$	40	A
$t_r =$	0,017	μs

Switching Definitions Boost

Figure 5 T1, T2

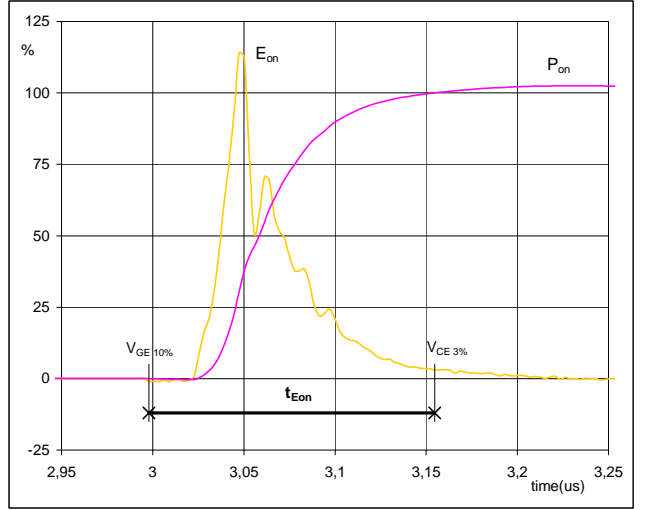
Turn-off Switching Waveforms & definition of t_{Eoff}



$P_{off} (100\%) = 28,02 \text{ kW}$
 $E_{off} (100\%) = 2,43 \text{ mJ}$
 $t_{Eoff} = 0,468 \text{ } \mu s$

Figure 6 T1, T2

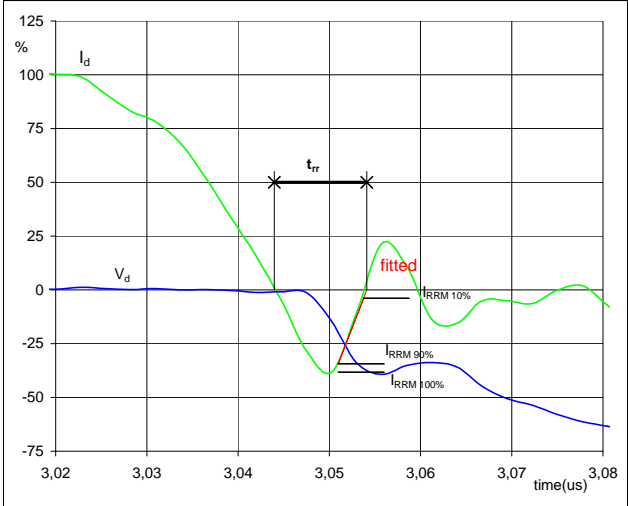
Turn-on Switching Waveforms & definition of t_{Eon}



$P_{on} (100\%) = 28,02 \text{ kW}$
 $E_{on} (100\%) = 1,22 \text{ mJ}$
 $t_{Eon} = 0,1567 \text{ } \mu s$

Figure 7 T1, T2

Turn-off Switching Waveforms & definition of t_{rr}

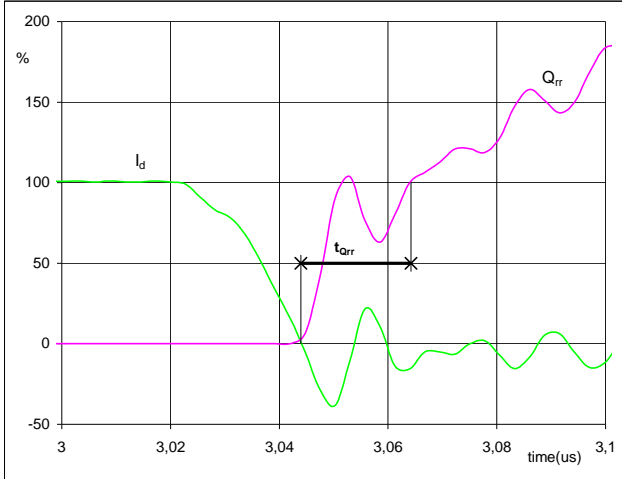


$V_d (100\%) = 700 \text{ V}$
 $I_d (100\%) = 40 \text{ A}$
 $I_{RRM} (100\%) = -15 \text{ A}$
 $t_{rr} = 0,009 \text{ } \mu s$

Switching Definitions Boost

Figure 8 D1, D2, D3, D4, D5, D6

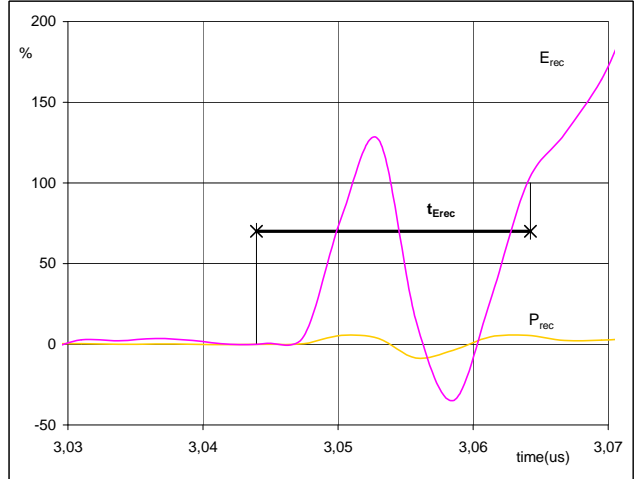
Turn-on Switching Waveforms & definition of t_{Qrr}
 (t_{Qrr} = integrating time for Q_{rr})



I_d (100%) =	40	A
Q_{rr} (100%) =	0,21	μC
t_{Qrr} =	0,02	μs

Figure 9 D1, D2, D3, D4, D5, D6

Turn-on Switching Waveforms & definition of t_{Erec}
 (t_{Erec} = integrating time for E_{rec})



P_{rec} (100%) =	28,02	kW
E_{rec} (100%) =	0,07	mJ
t_{Erec} =	0,02	μs

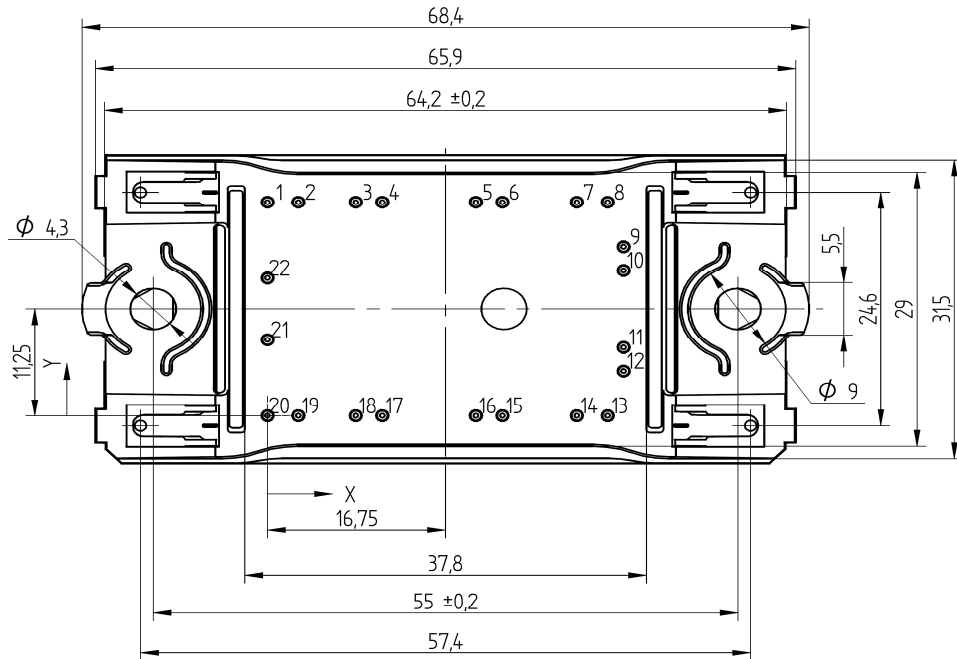
Ordering Code and Marking - Outline - Pinout

Ordering Code & Marking

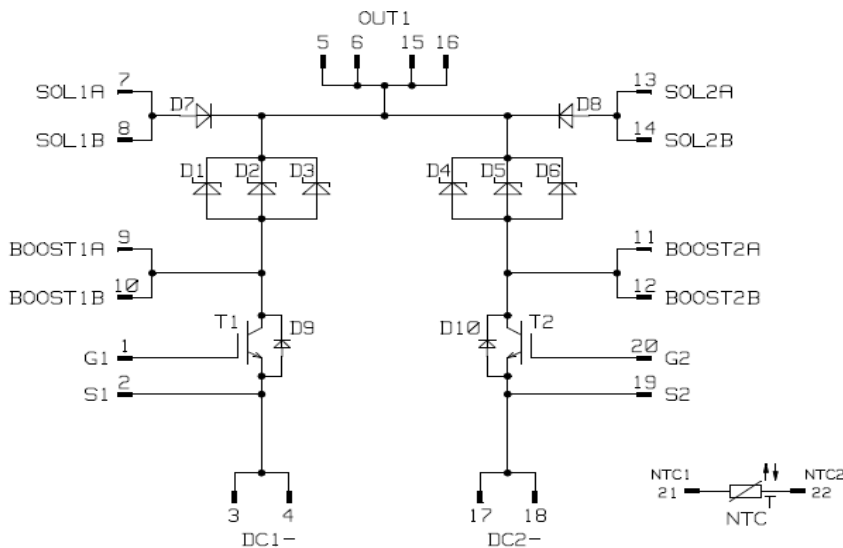
Version	Ordering Code	in DataMatrix as	in packaging barcode as
without thermal paste 12mm housing	V23990-P629-L63	P629L63	P629L63

Outline

Pin Table		
Pin	X	Y
1	0	22,5
2	2,9	22,5
3	8,3	22,5
4	10,8	22,5
5	19,6	22,5
6	22,1	22,5
7	29,1	22,5
8	32	22,5
9	33,5	17,8
10	33,5	15,3
11	33,5	7,2
12	33,5	4,7
13	32	0
14	29,1	0
15	22,1	0
16	19,6	0
17	10,8	0
18	8,3	0
19	2,9	0
20	0	0
21	0	8
22	0	14,5



Pinout



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